

2022 International Symposium on Semiconductor Manufacturing Intelligence (ISMI2022) November 11 - 13, 2022, Kinmen, Taiwan

Schedule

Day 1:	Friday, 11 November			
09:30-10:00	Registration	(Tan Kai Yong Conference Hall)		
10:00-10:10	Opening	(Tan Kai Yong Conference Hall)		
10:10-11:10	Keynote Speech I (Tan Kai Yong Conference Hall)			
	Industry Case: Operation Innovation in Semi-	conductor Fab with AI and Digital Twin		
	Professor Young Jae Jang, Korea Advanced Institute of Science and Technology (KAIST)			
11:10-12:10	Keynote Speech II (Tan Kai Yong Conference Hall)			
	Infrastructure for Assessing the Performance of Planning Approaches for Semiconductor			
	Supply Chains			
	Professor Lars Mönch, University of Hagen			
12:10-13:40		Lunch & Break		
13:40-14:30	Keynote Speech III	(Tan Kai Yong Conference Hall)		
	ration: ISRAEL smart Robotics Trends			
	Professor Yosi Lahad, Israel Intelligent Robotics Center (IIRC) Chair, Cooperation Committee			
	Malaysia Artificial Intelligence Roadmap			
	Professor Pok Wei Fong Deputy Dean of Faculty of Accountancy and Management, Universiti Tunku Abdul Rahman			
14:30-15:00	Tea Break	шуетені, Списегзій Типки Лойиі Киппип		
15:00-15:50	Keynote Speech IV	(Tan Kai Yong Conference Hall)		
13.00-13.30	GPU Parallel Computing for Smart Manufact	G		
	Dr. Andrew Liu, NVIDIA	aring and 2 ignar francismation		
15:50-16:40	Keynote Speech V	(Tan Kai Yong Conference Hall)		
	Modeling and solving complex job-shop scheduling problems			
	Professor Stéphane Dauzère-Pérès,			
	Center of Microelectronics in Provence (CMP) of	Mines Saint-Etienne		
Day 2:	Saturday, 12 November			
	(Main Building)			
13:00-14:30	Technical Sessions 1			
	Session I-1	Session I-2		
	Artificial Intelligence for Industrial Applications	Data-Driven Optimization and Analytics		
	(Main Building Room 110)	(Main Building Room 111)		
14:30-14:50	Tea Bre			
14:50-16:20	Technical Se			
	Session II-1	Session II-2		
	Optimization for Smart Manufacturing	Modeling and Decision Analysis		
14 20 14 50	(Main Building Room 110)	(Main Building Room 111)		
14:30-14:50	Tea Break			
16:40-17:10 17:30-20:00	Closing Ceremony			
Day 3:	Farewell Banquet Sunday, 13 November	(Ying Chun Ge Chinese Restaurant 盈春閣)		
09:00-12:00	Industry & Local Cultural Tour			
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I-1 Topic: Artificial Intelligence for Industrial Applications				
Locati	Location: Main Building Room 110 Time: 13:00 – 14:30			
Session Chair: Professor Tzu-Yen Hong				
ID	Title	Author		
5130	The Graph Neural Network–Based Dynamic Routing Algorithm for Overhead Hoist Transport Vehicles in	Jaeho Lee & Young Jae Jang		
	Semiconductor Fabrication Plants			
5987	Application of Machine Learning to Maritime Safety	Wu-Hsun Chung, Yi-Yang Hung & Chien-Chung Yuan		
5028	Maintenance Time Reduction for Semiconductor Manufacturing Tools	Sang-Hyun Cho, Jeongsun Ahn, Duyeon Kim, Dain Ham, Hongyeon Kim & Hyun-Jung Kim		
8445	UNISON Framework for Sustainability and an Illustration of PCB Company	Ju-Chien Chien, Yu-Quan Tseng, and Chen-Fu Chien		
8750	Industrial Product Demonstration in Metaverse using XR Technologies	Dawi Karomati Baroroh, Jie-Ke Pan, Shau-Min Chen & Chih-Hsing Chu		

I-2 Topic: Data-Driven Optimization and Analytics					
Location	Location: Main Building Room 111 Time: 13:00 – 14:30				
Session Chair: Professor You-Jin Park					
ID	Title	Author			
6198	A Novel Grid-based Algorithm for Decoder Routing in Semiconductor Design	Hongyeon Kim, Jeongsun Ahn, Chaeyoung Kim & Hyun-Jung Kim			
7084	A Conditional Recurrent Autoencoder for Anomaly Detection in Overhead Hoist Transport Systems According to their Operational State	Jiyoon Myung & Young Jae Jang			
9980	Applying Mathematical Programming for Master Production Scheduling in Multi-site Semiconductor Manufacturing- A Case Study of Company V	Chi-Cheng Lin, Yung-Chia Chang, Jonathan Chang, En-Cheng Lin, Yu-Wen Wang, Hsuan Yen & Chi-Wei Hu			
5070	Material Quality System in Solar Cell Manufacturer	Chia-Yen Lee, Yung-Lun Lin, Shu-Hung Lin & Taho Yang			
9989	A Novel Hybrid Under-Sampling for Semiconductor Wafer Defect Bin Classification	You-Jin Park, Rong Pan, Douglas C. Montgomery, Kyunghee Joo			



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II-1 Topic: Optimization for Smart Manufacturing					
Locati	on: Main Building Room 110 Time: 14:50 -	- 16:20			
Sessio	Session Chair: Professor Che-Wei Chou				
ID	Title	Author			
3831	A Comprehensive Survey of Metaheuristic Algorithms Applying in Mechanical Design Optimization Problems	Hsu-Hsing Chen & Feng-Cheng Yang			
5116	Storage Assignment Problem for Automated Warehouse in Manufacturing Systems	Sungwook Jang & Young Jae Jang			
6224	Multi-objective based Simplified Swarm Optimization for Container Loading Optimization with Practical Constraints	Truong Hoang Linh & Chen-Fu Chien			
9359	Education System for Automated Material Handling System Design with Digital Twin and LEGO Robotics	Young Jae Jang, Ye Bin Kim, Jeong Jun Lee & Chae Won Lim			
6009	An Artificial Neural Network Meta-model for Resource Allocation of Vehicle Fleets in the Automated Material Handling System	Che-Wei Chou, Wei-Cheng Chiu, Yu-Zhong Kang, Yao-Ting Chiang & Chia-Yu Lin			

II-2 Topic: Modeling and Decision Analysis					
Locati	Location: Main Building Room 111 Time: 14:50 – 16:20				
Sessio	Session Chair: Professor Chia-Yu Hsu				
ID	Title	Author			
1540	Discrete Lot-Sizing Problem of Single Machine based on Reinforcement Learning Approach	Tae Jong Park & Young Jae Jang			
0141	Strategic Dynamic Pricing Optimization by Thompson Sampling and Stochastic Programming	Tran Hong Van Nguyen, Chen-Fu Chien, Hsuan-An Kuo & Kang-Ting Ma			
2571	Exploring Compatibility of Information Services	Cheng-Han Wu, Pandu Dwi Luhur Pambudi & Yu-Wei Huang			
9904	Incumbent sales strategy in the presence of strategic consumers	Cheng-Han Wu, Netnapha Chamnisampan & Yan-Tong Liao			
7759	Extraction of Classification/Regression-qualified and Explainable Features for Deep Classifier/Regressor Modeling	Yun Chu & Jakey Blue			